

# First International Conference on Big Data Analysis and Deep Learning Applications

### Miyazaki, JAPAN

May 14-15, 2018

### **ORGANIZING COMMITTEE**

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Social Event Chair Soe Soe Khaing, MM Myint Myint Sein, MM

Social Event Chair TBD

Keynote Speakers Etsuo Chosa, JP Hiroyuki Yoshihara, JP KRV Raja Subramanian, IN

#### **VENUE**

Phoenix Seagaia Resort Miyazaki, Japan 2018 International Conference on Big Data and Deep Learning Applications (ICBDL 2018) is asking for submissions of technical papers for Oral presentations.

The ICBDL 2018 will bring together top technical professionals and academia to exchange information and results of state-of-the-art work on Big Data, Deep learning, Image Processing, Machine Learning and applications!

Student papers are particularly encouraged.

## **Call For Papers!**

### **TOPICS OF INTEREST (INCLUDE BUT NOT LIMITED TO)**

- Big Data Analysis for:
  - -Quality Education
  - -Medical Information System
  - -Surveillance Monitoring Systems
    - (i) Human Behaviors,
    - (ii) Animal Behaviors,
    - (iii) Health Care and etc.
- Machine Learning & Application
- Monitoring Systems by using Image Processing
- Deep Learning & Image Processing
- Convolutional Neural Networks and Applications
- Information and Communication
- Industrial Information Systems and applications.



### Contact

icbdm2018@gmail.com

### For More Information

www.cc.miyazaki-u.ac.jp/icbdm/



### **Important Dates**

Paper Submission	February 25,2018
Notification of Acceptance	March 05,2018
Camera-ready papers due date	March 12,2018
Conference Date	May 14-15,2018

Accepted and presented papers will be appeared in Springer series







